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10/807,197	03/24/2004	Kiyono Ikenaka	02860.0787 3745		
	7590 02/08/200 HENDERSON, FARAE	7 SOW, GARRETT & DUNNER	EXAMINER		
LLP 901 NEW YORK AVENUE, NW WASHINGTON, DC 20001-4413			TRAN, THANG V		
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If NO period for reply is specified above, the maximum statutory period will apply and will expire 6 MONTHS from the mailing date of this communication.

		Application No.		Applicant(s)
Office Action Summary		10/807,197		IKENAKA, KIYONO
		Examiner		Art Unit
		Thang V. Tran		2627
Period fo	The MAILING DATE of this communication apport	pears on the cove	r sheet with the co	rrespondence address
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Status				
2a) <u></u>	Responsive to communication(s) filed on <u>24 M</u> This action is FINAL . 2b) This Since this application is in condition for alloward closed in accordance with the practice under the second sec	s action is non-fin ince except for for	mal matters, pros	
Disposit	ion of Claims			·
5)□ 6)⊠ 7)⊠ 8)□ Applicat i 9)□ 10)⊠	Claim(s) 1-14 is/are pending in the application 4a) Of the above claim(s) is/are withdrated Claim(s) is/are allowed. Claim(s) 1-7 and 10-14 is/are rejected. Claim(s) 8 and 9 is/are objected to. Claim(s) are subject to restriction and/or are subject to restriction and/or are specification is objected to by the Examine The drawing(s) filed on 24 March 2004 is/are: Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath or declaration is objected to by the Examine The oath of the	wn from consider or election require er. a) accepted or drawing(s) be held tion is required if th	ment. b) □ objected to in abeyance. See 3 e drawing(s) is objected.	37 CFR 1.85(a). cted to. See 37 CFR 1.121(d).
Priority ι	under 35 U.S.C. § 119			
12)⊠ a)i	Acknowledgment is made of a claim for foreign All b) Some * c) None of: 1. Certified copies of the priority document Certified copies of the priority document None of: 2. Certified copies of the priority document Certified copies of the priority document Department Ception from the International Bureause the attached detailed Office action for a list	ts have been rece ts have been rece rity documents ha u (PCT Rule 17.2	eived. eived in Application ave been received (a)).	n No I in this National Stage
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1) Notice 2) Notice 3) Infon	the of References Cited (PTO-892) the of Draftsperson's Patent Drawing Review (PTO-948) mation Disclosure Statement(s) (PTO/SB/08) or No(s)/Mail Date	5) 🔲	Interview Summary (F Paper No(s)/Mail Date Notice of Informal Pat Other:	e

Claim Rejections - 35 USC § 112

1. Claims 11-13 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

It is unclear how limitations recited in these claims 11-13 are relatively operated with and structurally incorporated into limitations previously recited in claim 1.

Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 1-3, 6, 14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kitaura et al (US 6,610,380) in view of Komma et al (US 6,954,417).

Regarding claim 1, see Figs. 3 and 5 of Kitaura et al which disclose an optical pickup apparatus for a recording medium including at least a transparent protective substrate (1) with a thickness of t1, where 0.5 mm \leq t1 \leq 0.7 mm (see column 5, lines 48-50), a first information recording surface (7), an intermediate layer (8) and a second information recording surface (9) which are laminated in this order from a light source side along an optical axis, comprising: a first light source (10) to emit a light flux having a wavelength of λ 1, where 380 nm $\leq \lambda$ 1 \leq 450nm (see column 3, line 60 or column 7, line 9 as an example), an objective lens (6) to converge the light flux onto the first optical information recording medium. However, Kitaura et

al fails to suggest the use of a spherical aberration correcting structure to correct a spherical aberration caused in a converged spot on the first and second information recording surfaces due to an intermediate layer thickness when the objective lens converges at least a light flux emitted from the first light source on the first information and second information recording surfaces. Komma et al., according to Figs. 1, 4, 15 and 16, teaches the use of a spherical aberration correcting structure above for the purpose of correcting an aberration of the light beam depend on the thickness of interlayer in order to improve recorded information signal obtained from a the optical pickup (see element 4 in Fig. 15 for spherical aberration correcting structure and Fig. 1 for its operation). It would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the spherical aberration correcting structure as taught by Komma et al into the optical pickup of Kitaura et al for correcting an aberration of the light beam depend on the thickness of interlayer in order to improve recorded information signal obtained from a the optical pickup.

Regarding claim 2, see Fig. 16 of Komma et al which discloses the change of incident light beam by the aberration correction device (201) when position of the converged spot is shifted (jumped) from one recording layer to another recording layer.

Regarding claim 3, see Fig. 16 of Komma et al which discloses optical elements (21, 22) in the spherical aberration correcting structure are moved by driving means (24, 25) along an optical axis.

Regarding claim 6, see liquid crystal element 4 in Fig. 14 or 15 of Komma for limitation recited in this claim.

Regarding claim 14, since the optical pickup Kitaura et al modified by Komma having the same structure of objective lend and wavelength, limitation related to focus length recited in this claim is inherently included therein.

4. Claims 1, 3-7 and 11 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kitaura et al (US 6,610,380) in view of Kimara (US 6,950,383)

Regarding claim 1, see Figs. 3 and 5 of Kitaura et al which disclose an optical pickup apparatus for a recording medium including at least a transparent protective substrate (1) with a thickness of t1, where 0.5 mm \leq t1 \leq 0.7 mm (see column 5, lines 48-50), a first information recording surface (7), an intermediate layer (8) and a second information recording surface (9) which are laminated in this order from a light source side along an optical axis, comprising: a first light source (10) to emit a light flux having a wavelength of $\lambda 1$, where 380 nm $\leq \lambda 1 \leq$ 450nm (see column 3, line 60 or column 7, line 9 as an example), an objective lens (6) to converge the light flux onto the first optical information recording medium. However, Kitaura et al fails to suggest the use of a spherical aberration correcting structure to correct a spherical aberration caused in a converged spot on the first and second information recording surfaces due to an intermediate layer thickness when the objective lens converges at least a light flux emitted from the first light source on the first information and second information recording surfaces. Kimura, according to Figs. 1-4, teaches the use of a spherical aberration correcting structure above for the purpose of correcting an aberration of the light beam depend on the thickness of interlayer in order to improve recorded information signal obtained from a the optical pickup (see element 3 in Fig. 1 or 23 in Fig. 3). It would have been obvious to one of ordinary skill in

the art at the time the invention was made to incorporate the spherical aberration correcting structure as taught by Kimura into the optical pickup of Kitaura et al for correcting an aberration of the light beam depend on the thickness layer of a recording medium in order to improve recorded information signal obtained from a the optical pickup.

Regarding claim 3, see element 23 moved in the optical path by driver 13 as shown in Fig. 3 of Kimura for limitations recited in this claim.

Regarding claims 4 and 5, see Fig. 1 or 3 of Kimaru for limitation of finite light recited in these claims.

Regarding claims 6 and 7, see element 3 having three portions (b) as shown in Fig. 1 of Kimaru for limitations recited in these claims.

Regarding claim 11, see light source (1) is moved along the optical axis by driver 13 while optival element 4 is not moved during the operation of the pickup as shown Fig. 4 of Kimura for limitations recited in this claim.

5. Claims 1, 10, 12 and 13 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kitaura et al (US 6,610,380) in view of Katayama (US 2002/0181366).

Regarding claim 1, see Figs. 3 and 5 of Kitaura et al which disclose an optical pickup apparatus for a recording medium including at least a transparent protective substrate (1) with a thickness of t1, where 0.5 mm \leq t1 \leq 0.7 mm (see column 5, lines 48-50), a first information recording surface (7), an intermediate layer (8) and a second information recording surface (9) which are laminated in this order from a light source side along an optical axis, comprising: a first light source (10) to emit a light flux having a wavelength of λ 1, where 380 nm $\leq \lambda$ 1 \leq

450nm (see column 3, line 60 or column 7, line 9 as an example), an objective lens (6) to converge the light flux onto the first optical information recording medium. However, Kitaura et al fails to suggest the use of a spherical aberration correcting structure to correct a spherical aberration caused in a converged spot on the first and second information recording surfaces due to an intermediate layer thickness when the objective lens converges at least a light flux emitted from the first light source on the first information and second information recording surfaces. Katayama, according to Figs. 8 and 9 or 15 and 16, teaches the use of a spherical aberration correcting structure above for the purpose of correcting an aberration of the light beam depend on the thickness of interlayer in order to improve recorded information signal obtained from a the optical pickup (see element shown in Fig. 9 or 16). It would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the spherical aberration correcting structure as taught by Katayama into the optical pickup of Kitaura et al for correcting an aberration of the light beam depend on the thickness layer of a recording medium in order to improve recorded information signal obtained from a the optical pickup.

Regarding claim 10, see the operation of wavelength selective filter 3 in Fig. 8 or 15, or element 22a in Fig. 21 relative to the change of wavelength of the light beam generated from different light sources 1a, 1a and 1c for limitation recited in this claim.

Regarding claims 12 and 13, as indicated above, it is not clear from these claims how limitations recited in these claims are incorporated and operated relatively to limitations recited in claim 1. However, limitations recited in these claims are nothing more than a well known recording/reproducing apparatus for a standard DVD and CD, see Fig. 15, 22, 29 or 30 of Katayama for these limitations.

Allowable Subject Matter

- 6. Claims 8 and 9 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.
- 7. Claims 8 and 9 are allowable over the prior art of record because the prior art of record, considered alone or in combination, fails to suggest or fairly teach an optical pickup including all of limitations as recited in claim 8 or 9.

Cited References

- 8. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. The cited references relate to an optical pickup having an aberration correction device for correcting an aberration of a light beam in according to a detected thickness of an optical recording medium.
- 9. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Thang V. Tran whose telephone number is (571) 272-7595. The examiner can normally be reached on M-F 9:30AM-6:00PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nguyen Hoa can be reached on (571) 272-7579. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Thang V. Tran

Primary Examiner

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